S	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/965,784	MCELWAIN ET AL.	
Examiner	Art Unit	
Tuan H. Nauven	2618	

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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All searches are on EAST data base.	12/15/2006	T.N
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